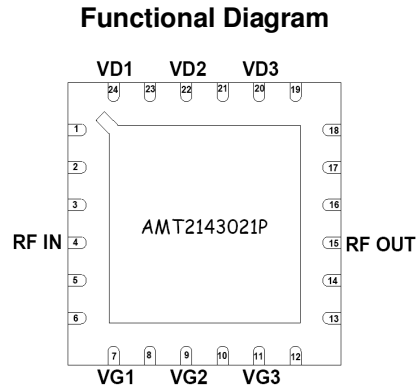


9 – 11 GHz Medium Power Amplifier

Features

- ◆ Frequency Range : 9 – 11GHz
- ◆ 20 dBm output P1dB
- ◆ 28 dB Gain
- ◆ 30% PAE
- ◆ High IP3
- ◆ Input Return Loss > 8 dB
- ◆ Output Return Loss > 8 dB
- ◆ Dual bias operation
- ◆ No external matching required
- ◆ DC decoupled input and output
- ◆ 0.5 μm InGaAs pHEMT Technology
- ◆ Open cavity QFN Package



Typical Applications

- ◆ RADAR
- ◆ Military & space
- ◆ LMDS, VSAT

Description

The AMT2143021P is a X-band Medium Power Amplifier with 20dBm output P1dB. The PA uses two stages of amplification and operates in 9 – 11 GHz frequency range. The PA features 28 dB of gain with input and output return loss 8dB respectively. The PA has a high IP3 of 31dBm and 30% PAE. This feature enables it to be used in the applications requiring efficiency along with linearity. The chip operates with dual bias supply voltage. The die is fabricated using a reliable 0.5 μm InGaAs pHEMT technology.

The package used is a SMD open cavity QFN Package with base metal made up of copper composite.

Absolute Maximum Ratings ⁽¹⁾

Parameter	Absolute Maximum	Units
Drain bias voltage (Vd)	+10	volts
Drain current (Id)	0.13	A
RF input power (RF _{in} at Vd=8V)	22	dBm
Operating temperature	-50 to +85	°C
Storage Temperature	-65 to +150	°C

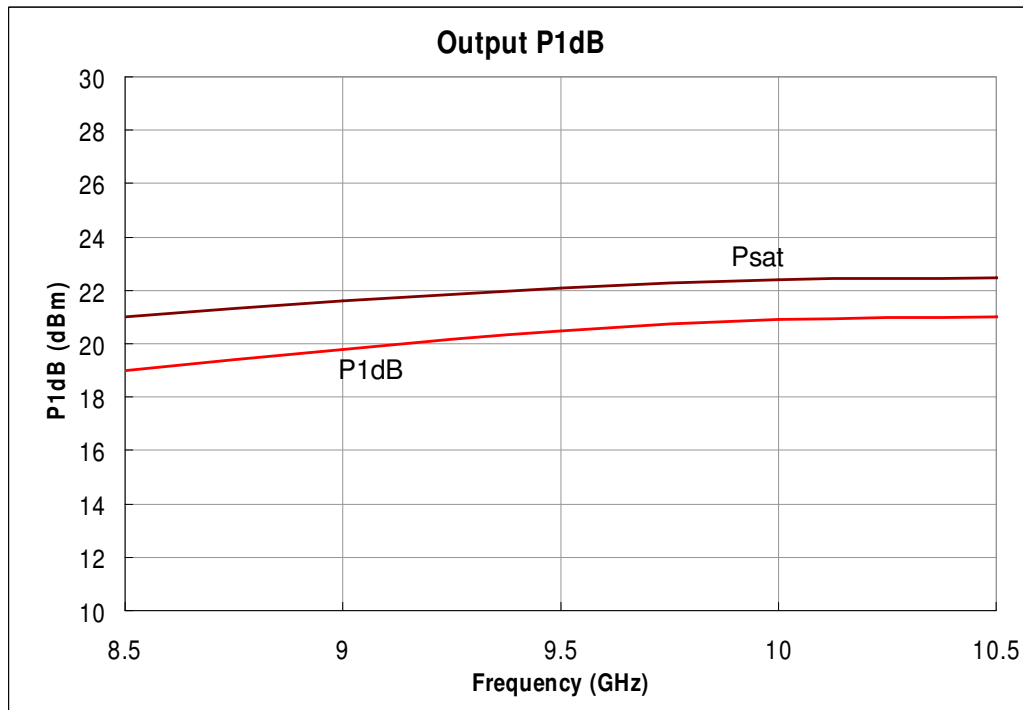
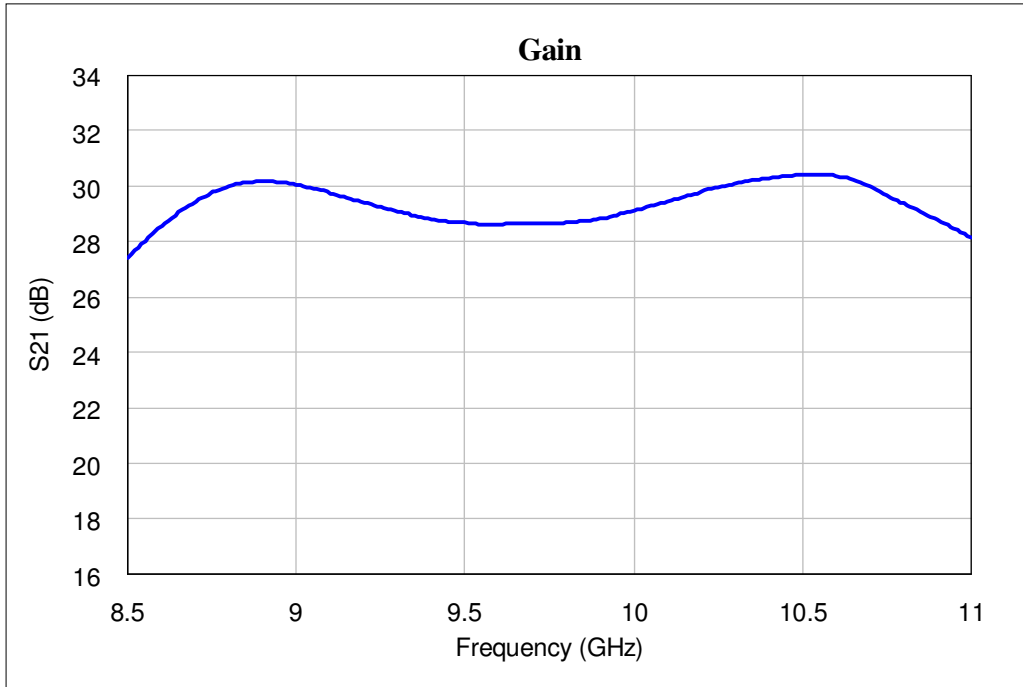
1. Operation beyond these limits may cause permanent damage to the component

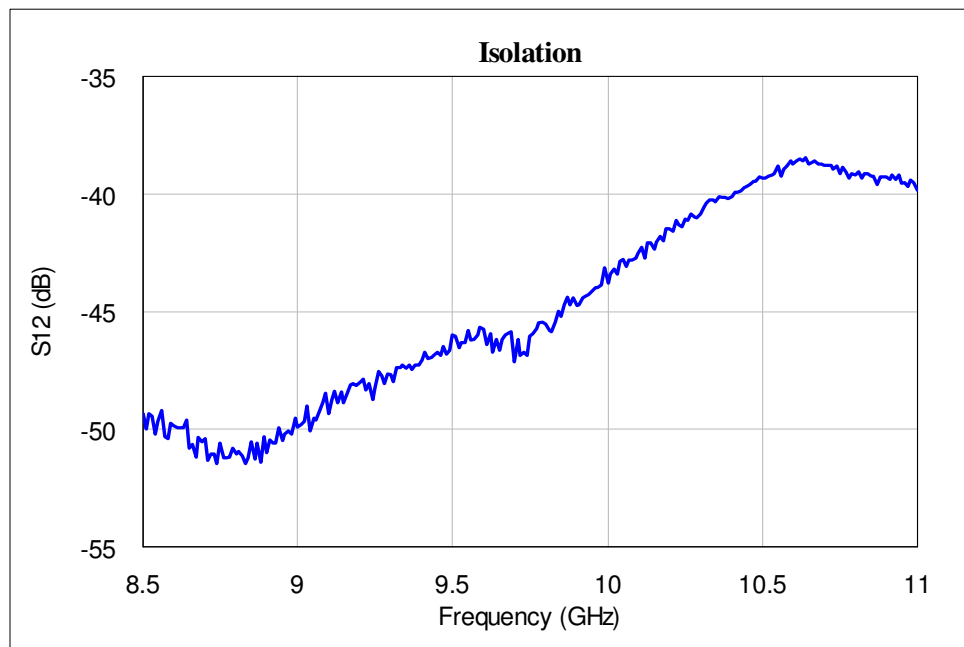
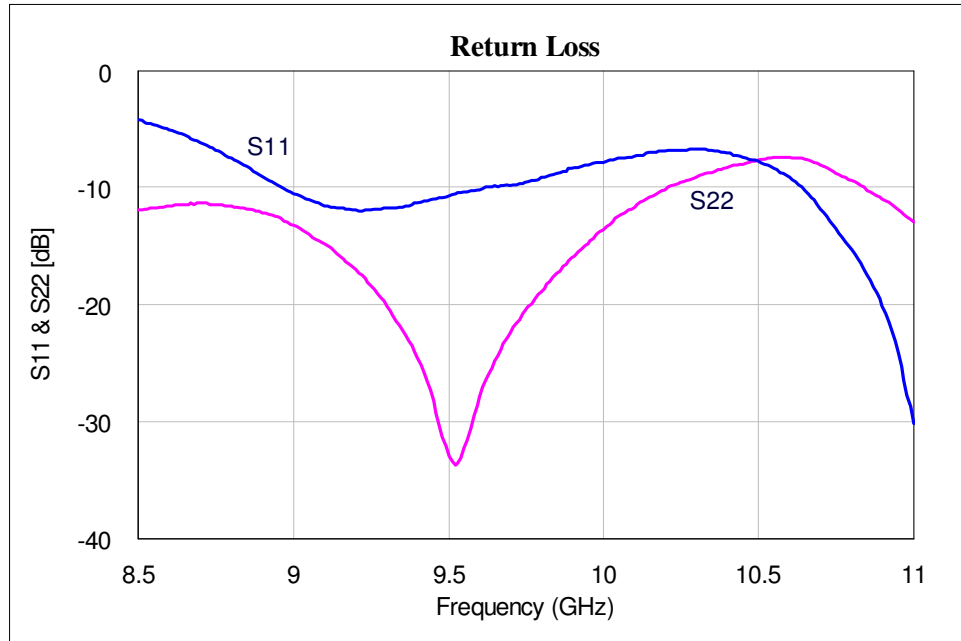
Electrical Specifications ⁽¹⁾ @ T_A = 25 °C, V_d = 8V, V_g = -1V, Z_o = 50 Ω

Parameter	Typ.	Units
Frequency Range	9 – 11	GHz
Gain	28	dB
Gain Flatness	+/-1	dB
Output Power (P1 dB)	20	dBm
Input Return Loss	8	dB
Output Return Loss	8	dB
Saturated output power (P _{sat})	22	dBm
Output Third Order Intercept (IP3)	31	dBm
Power Added Efficiency (PAE)	30%	--
Supply Current (I _{dq})	0.75	mA

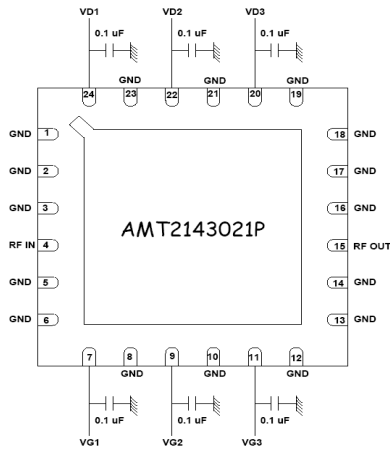
Note:

1. Electrical specifications as measured in test fixture.

Test fixture data
 $V_d = 8V, V_g = -1V, \text{Total Current} = 75mA, T_A = 25^\circ C$


Test fixture data $V_d = 8V$, $V_g = -1V$, Total Current = 75mA, $T_A = 25^\circ C$ 

Pin details



Top View

Note:

- | | | |
|---------------------|---|---------------|
| 1. Pad no. 4 | : | RF IN |
| 2. Pad no. 7,9,11 | : | Vg1, Vg2, Vg3 |
| 3. Pad no. 24,23,20 | : | Vd1, Vd2, Vd3 |
| 4. Pad no. 15 | : | RF OUT |

Recommended Assembly Diagram

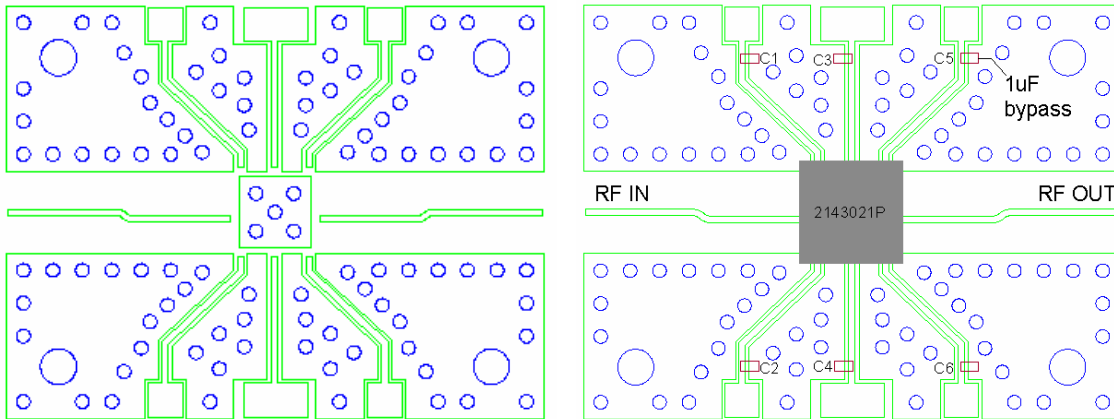


Fig: PCB Drawing

Fig: Package assembled on PCB

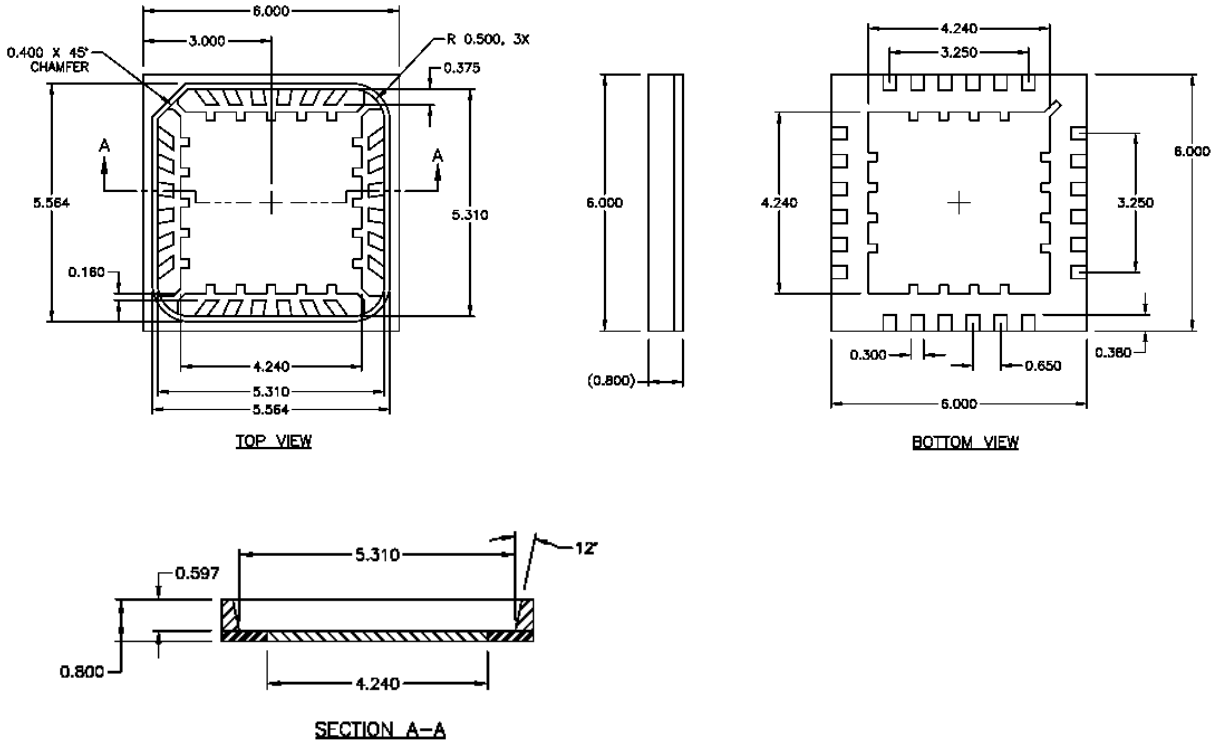
Note :

1. Input and output 50 ohm lines are on 5 mil RT Duroid substrate
2. 0.1 μ F and 1 μ F capacitors may be additionally used as a second level of bypass for reliable operation
3. The RF input & output ports are DC decoupled on-chip.
4. Proper heat sink like Aluminium or copper to be used for better reliability of package

Die attach: For Epoxy attachment, use of a two-component conductive epoxy is recommended. An epoxy fillet should be visible around the total die periphery. If Eutectic attachment is preferred, use of fluxless AuSn (80/20) 1-2 mil thick preform solder is recommended. Use of AuGe preform should be strictly avoided.

Wire bonding: For DC pad connections use either ball or wedge bonds. For best RF performance, use of 150 - 200 μ m length of wedge bonds is advised. Single Ball bonds of 250-300 μ m though acceptable, may cause a deviation in RF performance.

Package outline drawing



GaAs MMIC devices are susceptible to Electrostatic discharge. Proper precautions should be observed during handling, assembly & testing

All information and Specifications are subject to change without prior notice